Power MOSFET 2 Amps, 25 Volts P-Channel SO-8, Dual

These miniature surface mount MOSFETs feature ultra low $R_{DS(on)}$ and true logic level performance. They are capable of withstanding high energy in the avalanche and commutation modes and the drain-to-source diode has a low reverse recovery time. These devices are designed for use in low voltage, high speed switching applications where power efficiency is important. Typical applications are dc-dc converters, and power management in portable and battery powered products such as computers, printers, cellular and cordless phones. They can also be used for low voltage motor controls in mass storage products such as disk drives and tape drives. The avalanche energy is specified to eliminate the guesswork in designs where inductive loads are switched and offer additional safety margin against unexpected voltage transients.

Features

- Ultra Low R_{DS(on)} Provides Higher Efficiency and Extends Battery Life
- Logic Level Gate Drive Can Be Driven by Logic ICs
- Miniature SO–8 Surface Mount Package Saves Board Space
- Diode Is Characterized for Use In Bridge Circuits
- Diode Exhibits High Speed, with Soft Recovery
- I_{DSS} Specified at Elevated Temperatures
- Avalanche Energy Specified
- Mounting Information for SO-8 Package Provided
- This is a Pb–Free Device

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted) (Note 1)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	V _{DSS}	25	Vdc
Gate-to-Source Voltage - Continuous	V _{GS}	± 20	Vdc
$\begin{array}{l} \text{Drain Current} - \text{Continuous} @ T_A = 25^\circ\text{C} \\ - \text{Continuous} @ T_A = 100^\circ\text{C} \\ - \text{Single Pulse} (t_p \leq 10 \ \mu\text{s}) \end{array}$	I _D I _D I _{DM}	2.5 1.7 13	Adc Apk
Total Power Dissipation @ T _A = 25°C (Note 2) Derate above 25°C	P _D	2.0 16	W mW/°C
Operating and Storage Temperature Range	T _J , T _{stg}	-55 to 150	°C
$ \begin{array}{l} \mbox{Single Pulse Drain-to-Source Avalanche} \\ \mbox{Energy} - \mbox{Starting } T_J = 25^\circ C \\ \mbox{(V_{DD}} = 20 \mbox{ Vdc}, \mbox{V}_{GS} = 10 \mbox{ Vdc}, \mbox{Peak} \\ \mbox{I}_L = 7.0 \mbox{ Apk}, \mbox{L} = 10 \mbox{ mH}, \mbox{R}_G = 25 \Omega \\ \end{array} $	E _{AS}	245	mJ
Thermal Resistance, Junction-to-Ambient (Note 2)	R _{θJA}	62.5	°C/W
Maximum Lead Temperature for Soldering Purposes, 0.0625" from case for 10 sec.	ΤL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Negative sign for P-Channel device omitted for clarity.

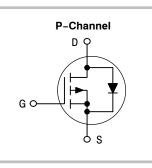
 Mounted on 2" square FR4 board (1" sq. 2 oz. Cu 0.06" thick single sided) with one die operating, 10 sec. max.

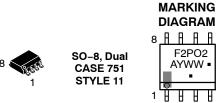


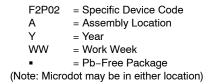
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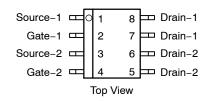
2 AMPERES, 25 VOLTS R_{DS(on)} = 250 m Ω







PIN ASSIGNMENT



ORDERING INFORMATION

Device	Package	Shipping [†]
MMDF2P02ER2G	SO-8 (Pb-Free)	2500 Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

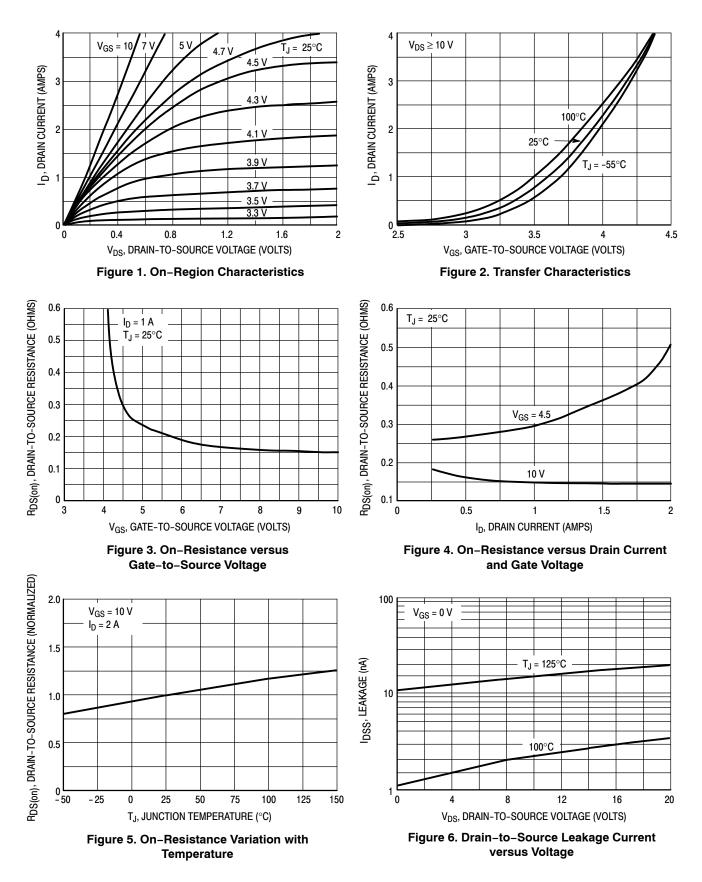
ELECTRICAL CHARACTERISTICS ($T_A = 25^{\circ}C$ unless otherwise noted) (Note 3)

Chara	Symbol	Min	Тур	Max	Unit	
OFF CHARACTERISTICS			•	·	-	·
$\begin{array}{l} Drain-to-Source \ Breakdown \ Voltage \\ (V_{GS}=0 \ Vdc, \ I_D=250 \ \mu Adc) \\ Temperature \ Coefficient \ (Positive) \end{array}$	V _{(BR)DSS}	25 -	_ 2.2		Vdc mV/°C	
Zero Gate Voltage Drain Current ($V_{DS} = 20$ Vdc, $V_{GS} = 0$ Vdc) ($V_{DS} = 20$ Vdc, $V_{GS} = 0$ Vdc, $T_J = 100$	I _{DSS}			1.0 10	μAdc	
Gate-Body Leakage Current (V _{GS} = \pm	20 Vdc, V _{DS} = 0)	I _{GSS}	-	-	100	nAdc
ON CHARACTERISTICS (Note 4)						
Gate Threshold Voltage $(V_{DS} = V_{GS}, I_D = 250 \ \mu Adc)$ Temperature Coefficient (Negative)	V _{GS(th)}	1.0 -	2.0 3.8	3.0 -	Vdc	
Static Drain-to-Source On-Resistance ($V_{GS} = 10$ Vdc, $I_D = 2.0$ Adc) ($V_{GS} = 4.5$ Vdc, $I_D = 1.0$ Adc)		R _{DS(on)}		0.19 0.3	0.25 0.4	Ω
Forward Transconductance ($V_{DS} = 3.0$	9fs	1.0	2.8	-	Mhos	
DYNAMIC CHARACTERISTICS						
Input Capacitance		C _{iss}	-	340	475	pF
Output Capacitance	(V _{DS} = 16 Vdc, V _{GS} = 0 Vdc, f = 1.0 MHz)	C _{oss}	-	220	300	
Transfer Capacitance		C _{rss}	-	75	150	
SWITCHING CHARACTERISTICS (No	ote 5)					
Turn-On Delay Time		t _{d(on)}	-	20	40	ns
Rise Time	(V _{DD} = 10 Vdc, I _D = 2.0 Adc,	t _r	-	40	80	
Turn-Off Delay Time	V_{GS} = 5.0 Vdc, R_{G} = 6.0 Ω)	t _{d(off)}	-	53	106	
Fall Time		t _f	-	41	82	
Turn-On Delay Time		t _{d(on)}	-	13	26	
Rise Time	(V _{DD} = 10 Vdc, I _D = 2.0 Adc,	t _r	-	29	58	
Turn-Off Delay Time	$V_{GS} = 10 \text{ Vdc}, \overline{R}_{G} = 6.0 \Omega$	t _{d(off)}	-	30	60	
Fall Time		t _f	-	28	56	
Gate Charge		QT	-	10	15	nC
	$(V_{DS} = 16 \text{ Vdc}, I_D = 2.0 \text{ Adc}, \\ V_{GS} = 10 \text{ Vdc})$	Q ₁	-	1.0	-	1
		Q ₂	-	3.5	-	1
		Q ₃	-	3.0	-	
SOURCE-DRAIN DIODE CHARACTE	RISTICS					
Forward On–Voltage (Note 4)	$(I_S = 2.0 \text{ Adc}, V_{GS} = 0 \text{ Vdc})$	V _{SD}	-	1.5	2.0	Vdc

Forward On-Voltage (Note 4)	$(I_{\rm S}$ = 2.0 Adc, V _{GS} = 0 Vdc)	V _{SD}	-	1.5	2.0	Vdc
Reverse Recovery Time		t _{rr}	-	32	64	ns
See Figure 11	(I _S = 2.0 Adc, V _{GS} = 0 Vdc,	ta	-	19	-	
	dI _S /dt = 100 A/µs)	t _b	-	12	-	
Reverse Recovery Storage Charge		Q _{RR}	-	0.035	-	μC

Negative sign for P–Channel device omitted for clarity.
Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
Switching characteristics are independent of operating junction temperature.

TYPICAL ELECTRICAL CHARACTERISTICS



POWER MOSFET SWITCHING

Switching behavior is most easily modeled and predicted by recognizing that the power MOSFET is charge controlled. The lengths of various switching intervals (Δt) are determined by how fast the FET input capacitance can be charged by current from the generator.

The published capacitance data is difficult to use for calculating rise and fall because drain–gate capacitance varies greatly with applied voltage. Accordingly, gate charge data is used. In most cases, a satisfactory estimate of average input current ($I_{G(AV)}$) can be made from a rudimentary analysis of the drive circuit so that

 $t = Q/I_{G(AV)}$

During the rise and fall time interval when switching a resistive load, V_{GS} remains virtually constant at a level known as the plateau voltage, V_{SGP} . Therefore, rise and fall times may be approximated by the following:

 $t_r = Q_2 x R_G / (V_{GG} - V_{GSP})$

 $t_f = Q_2 x R_G / V_{GSP}$

where

1000

800

600

400

200

0

10

C, CAPACITANCE (pF)

 V_{GG} = the gate drive voltage, which varies from zero to V_{GG} R_G = the gate drive resistance

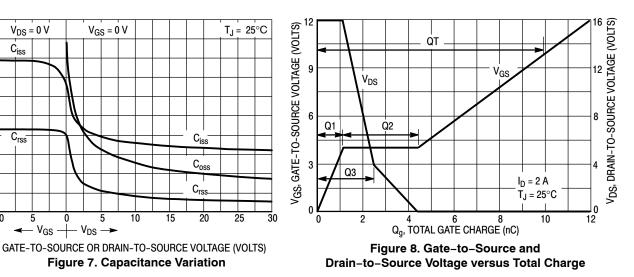
and Q_2 and V_{GSP} are read from the gate charge curve.

During the turn-on and turn-off delay times, gate current is not constant. The simplest calculation uses appropriate values from the capacitance curves in a standard equation for voltage change in an RC network. The equations are:

$$\begin{split} t_{d(on)} &= R_G \; C_{iss} \; In \; [V_{GG}/(V_{GG} - V_{GSP})] \\ t_{d(off)} &= R_G \; C_{iss} \; In \; (V_{GG}/V_{GSP}) \end{split}$$

The capacitance (C_{iss}) is read from the capacitance curve at a voltage corresponding to the off-state condition when calculating $t_{d(on)}$ and is read at a voltage corresponding to the on-state when calculating $t_{d(off)}$.

At high switching speeds, parasitic circuit elements complicate the analysis. The inductance of the MOSFET source lead, inside the package and in the circuit wiring which is common to both the drain and gate current paths, produces a voltage at the source which reduces the gate drive current. The voltage is determined by Ldi/dt, but since di/dt is a function of drain current, the mathematical solution is complex. The MOSFET output capacitance also complicates the mathematics. And finally, MOSFETs have finite internal gate resistance which effectively adds to the resistance of the driving source, but the internal resistance is difficult to measure and, consequently, is not specified.



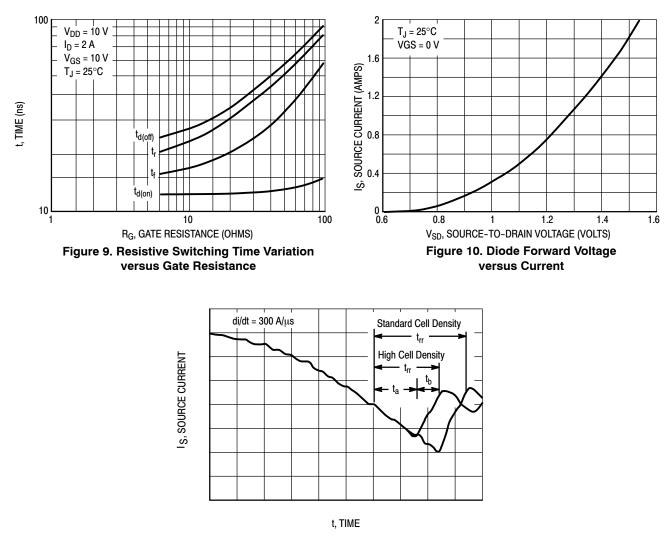


Figure 11. Reverse Recovery Time (t_{rr})

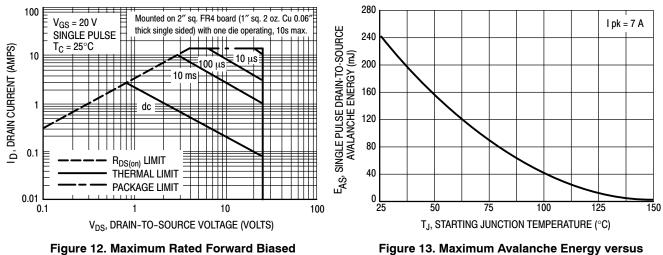
SAFE OPERATING AREA

The Forward Biased Safe Operating Area curves define the maximum simultaneous drain-to-source voltage and drain current that a transistor can handle safely when it is forward biased. Curves are based upon maximum peak junction temperature and a case temperature (T_C) of 25°C. Peak repetitive pulsed power limits are determined by using the thermal response data in conjunction with the procedures discussed in AN569, "Transient Thermal Resistance – General Data and Its Use."

Switching between the off-state and the on-state may traverse any load line provided neither rated peak current (I_{DM}) nor rated voltage (V_{DSS}) is exceeded, and that the transition time (t_p , t_f) does not exceed 10 µs. In addition the total power averaged over a complete switching cycle must not exceed ($T_{J(MAX)} - T_C$)/($R_{\theta JC}$).

This MOSFET can be safely used in switching circuits with unclamped inductive loads. For reliable operation, the stored energy from circuit inductance dissipated in the transistor while in avalanche must be less than the rated limit and must be adjusted for operating conditions differing from those specified. Although industry practice is to rate in terms of energy, avalanche energy capability is not a constant. The energy rating decreases non-linearly with an increase of peak current in avalanche and peak junction temperature.

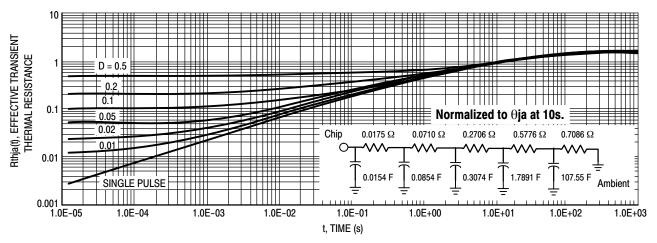
Although many MOSFETs can withstand the stress of drain-to-source avalanche at currents up to rated pulsed current (I_{DM}), the energy rating is specified at rated continuous current (I_D), in accordance with industry custom. The energy rating must be derated for temperature as shown in the accompanying graph (Figure 13). Maximum energy at currents below rated continuous I_D can safely be assumed to equal the values indicated.

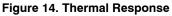


Safe Operating Area

Figure 13. Maximum Avalanche Energy versus **Starting Junction Temperature**

TYPICAL ELECTRICAL CHARACTERISTICS





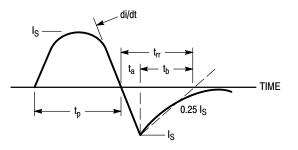


Figure 15. Diode Reverse Recovery Waveform





*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

STYLES ON PAGE 2

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STYLE 1: PIN 1. EMITTER COLLECTOR 2. COLLECTOR 3. 4. EMITTER EMITTER 5. BASE 6. 7 BASE EMITTER 8. STYLE 5: PIN 1. DRAIN 2. DRAIN 3. DRAIN DRAIN 4. GATE 5. 6. GATE SOURCE 7. 8. SOURCE STYLE 9: PIN 1. EMITTER, COMMON COLLECTOR, DIE #1 COLLECTOR, DIE #2 2. З. EMITTER, COMMON 4. 5. EMITTER, COMMON 6 BASE. DIE #2 BASE, DIE #1 7. 8. EMITTER, COMMON STYLE 13: PIN 1. N.C. 2. SOURCE 3 GATE 4. 5. DRAIN 6. DRAIN DRAIN 7. DRAIN 8. STYLE 17: PIN 1. VCC 2. V2OUT V10UT З. TXE 4. 5. RXE 6. VFF 7. GND 8. ACC STYLE 21: CATHODE 1 PIN 1. 2. CATHODE 2 3 CATHODE 3 CATHODE 4 4. 5. CATHODE 5 6. COMMON ANODE COMMON ANODE 7. 8. CATHODE 6 STYLE 25: PIN 1. VIN 2 N/C REXT З. 4. GND 5. IOUT 6. IOUT IOUT 7. 8. IOUT STYLE 29: BASE, DIE #1 PIN 1. 2 EMITTER, #1 BASE, #2 З. EMITTER, #2 4. 5 COLLECTOR, #2 COLLECTOR, #2 6.

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STYLE 3: PIN 1. DRAIN, DIE #1 DRAIN, #1 2. DRAIN, #2 З. 4. DRAIN, #2 GATE, #2 5. SOURCE, #2 6. 7 GATE #1 8. SOURCE, #1 STYLE 7: PIN 1. INPUT 2. EXTERNAL BYPASS THIRD STAGE SOURCE GROUND З. 4. 5. DRAIN 6. GATE 3 SECOND STAGE Vd 7. FIRST STAGE Vd 8. STYLE 11: PIN 1. SOURCE 1 GATE 1 SOURCE 2 2. 3. GATE 2 4. 5. DRAIN 2 6. DRAIN 2 DRAIN 1 7. 8. DRAIN 1 STYLE 15: PIN 1. ANODE 1 2. ANODE 1 ANODE 1 3 ANODE 1 4. 5. CATHODE, COMMON CATHODE, COMMON CATHODE, COMMON 6. 7. CATHODE, COMMON 8. STYLE 19: PIN 1. SOURCE 1 GATE 1 SOURCE 2 2. 3. GATE 2 4. 5. DRAIN 2 6. MIRROR 2 DRAIN 1 7. 8. **MIRROR 1** STYLE 23: PIN 1. LINE 1 IN COMMON ANODE/GND COMMON ANODE/GND 2. 3 LINE 2 IN 4. LINE 2 OUT 5. COMMON ANODE/GND COMMON ANODE/GND 6. 7. LINE 1 OUT 8. STYLE 27: PIN 1. ILIMIT 2 OVI 0 UVLO З. 4. INPUT+ 5. SOURCE SOURCE 6. SOURCE 7. 8 DRAIN

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STYLE 4: ANODE ANODE PIN 1. 2. ANODE З. 4. ANODE ANODE 5. 6. ANODE 7 ANODE COMMON CATHODE 8. STYLE 8: PIN 1. COLLECTOR, DIE #1 2. BASE, #1 BASE #2 3. COLLECTOR, #2 4. COLLECTOR, #2 5. 6. EMITTER, #2 EMITTER, #1 7. 8. COLLECTOR, #1 STYLE 12: PIN 1. SOURCE SOURCE 2. 3. 4. GATE 5. DRAIN 6. DRAIN DRAIN 7. 8. DRAIN STYLE 16: PIN 1. EMITTER, DIE #1 2. BASE, DIE #1 EMITTER, DIE #2 3 BASE, DIE #2 4. 5. COLLECTOR, DIE #2 6. COLLECTOR, DIE #2 COLLECTOR, DIE #1 7. COLLECTOR, DIE #1 8. STYLE 20: PIN 1. SOURCE (N) GATE (N) SOURCE (P) 2. 3. 4. GATE (P) 5. DRAIN 6. DRAIN DRAIN 7. 8. DRAIN STYLE 24: PIN 1. BASE 2. EMITTER 3 COLLECTOR/ANODE COLLECTOR/ANODE 4. 5. CATHODE 6. CATHODE COLLECTOR/ANODE 7. 8. COLLECTOR/ANODE STYLE 28: PIN 1. SW_TO_GND 2. DASIC OFF DASIC_SW_DET З. 4. GND 5. 6. V MON VBULK 7. VBULK 8 VIN

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SOURCE 1/DRAIN 2

7.

8. GATE 1

7.

8

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COLLECTOR, #1

COLLECTOR, #1

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